

<b>Notice of References Cited</b>	Application/Control No. 10/025,610	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
	Examiner Paul Nguyen-Ba	Art Unit 2176	Page 1 of 1

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	C	US-6,108,698	08-2000	Tenev et al.	709/220
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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